

The DCP-HTR probe delivers fA-level measurement capability from -65°C to 300°C for advanced characterization and reliability testing. Its unique design offers superior guarding and shielding over-temperature, overcoming the high-temperature performance limitations of standard coaxial needles. For full-triaxial current/voltage over-temperature measurements, using triaxial cables, the DCP-HTR probe should be used with Cascade Microtech's parametric probing systems with MicroChamber® and AttoGuard® technology. When used with MicroChamber, the DCP-HTR allows full utilization of semiconductor parametric test instruments. The optional probe tips with small diameter are ideal for probing pads as small as 30 µm x 30 µm.

FEATURES / BENEFITS

Low-noise electrical performance	Ultra-low, fA-level current and fF-level capacitance measurements from -65°C to + 300°C
Microstrip probe tips	Guarantees fully-guarded measurements to fA and fF levels
Precision, industry-standard SSMC 50 Ω connectors	Individual connectors provide force-sense connection for quasi-Kelvin and CV measurements
Selection of probe tip diameters	Allows probing of different pad materials and sizes
Easily replaceable probe tips	Fast replacement of worn probes without the need for tools



GENERAL SPECIFICATIONS

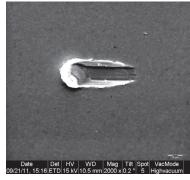
>500 V
>1 x 10E ¹³ Ω
150 MHz
-65°C to +300°C (above 250°C: 8 hours max operation)
±10 fA at -65°C to 200°C, ±20 fA at 200°C to 300°C
<100 fF (probe tip in air at room temperature)
50 Ω
Gold plated
SSMC
30 μm x 30 μm (10 μm radius tips required)

TIP SPECIFICATIONS

Tip material	Tungsten
Contact force	3 gram/25 µm
Scrub	Typically 2.5:1 skate ratio (25 μm overdrive = 10 μm skate)
MicroChamber compatible	Yes
AttoGuard compatible	Yes

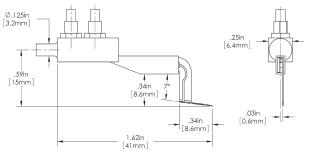
PN (10-PK)	TIP SHAPE	TIP Ø (μm)	TIP Ø TOL (µm)	DEPTH	BEAM ANGLE	
154-001	radius	19	+/- 3.8	0.358	0.358 7°	
154-003		10	+/- 2.5			

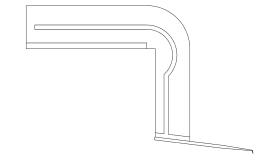




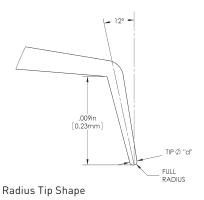
Radius Tip

154-001 19 µm

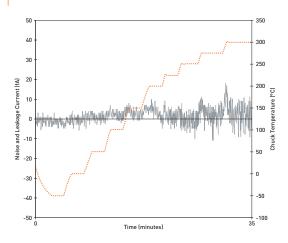




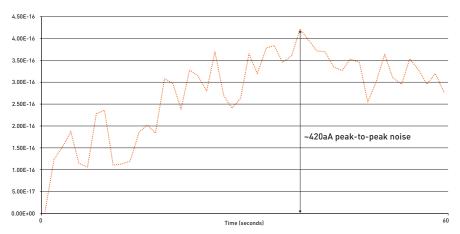
DCP-HTR Probe Body



PERFORMANCE



Typical DCP-HTR probe noise and leakage over temperature when used in conjunction with Cascade Microtech probe station with MicroChamber and AttoGuard technology



Typical DCP-HTR probe noise and leakage at ambient when used in conjunction with Cascade Microtech probe station with MicroChamber and AttoGuard technology

ORDERING INFORMATION

PART NUMBER	DESCRIPTION	
DCP-HTR	DCP-HTR DC probe holder	
151-286	Thermally-stable probe arms for DCP-HTR (for MS-1 positioners, triax)	
151-287	Thermally-stable probe arms for DCP-HTR (for DCM positioners, triax)	
151-288	Thermally-stable probe arms for DCP-HTR (for DCM positioners, coax)	
154-001	Replaceable probe tips, box of 10, radius tip, 19 µm diameter	
154-003	Replaceable probe tips, box of 10, radius tip, 10 µm diameter	
138-020	Edge Sense, single blade ceramic needle for DCP-HTR probe body	

© Copyright 2015 Cascade Microtech, Inc. All rights reserved. Cascade Microtech, AttoGuard and MicroChamber are registered trademarks of Cascade Microtech, Inc. All other trademarks are the property of their respective owners.

Data subject to change without notice

DCPHTR-DS-0715

Cascade Microtech, Inc. Corporate Headquarters toll free: +1-800-550-3279 phone: +1-503-601-1000 email: cmi_sales@cmicro.com

Germany phone: +49-35240-73-333 ${\scriptstyle \mathsf{email}: \, \mathsf{cmg_sales}@\mathsf{cmicro.com}}$

phone: +81-3-5615-5150 email: cmj_sales@cmicro.com

phone: +86-21-3330-3188 email: cmc_sales@cmicro.com

Singapore phone: +65-6873-7482 email: cms_sales@cmicro.com

phone: +886-3-5722810 ${\scriptstyle \mathsf{email}: \, \mathsf{cmt_sales}@\mathsf{cmicro.com}}$

